Siled 10/24/03

PTO/SB/08A (08-03)

Under the Paperwork Reduction Act of 1995, no persons are required	U.S. Pelent end Trade to respond to a collection of informa	mark Office; U.S. OEPARTMENT OF COMMERCI tion unless it contains a valid OMB control number			
	Complete if Known				
Substitute for form 1449/PTD  INFORMATION DISCLOSURE	Application Number				
	Filing Date	10/24/2003			
	First Named Inventor	WARREN M. FARNWORTH			
STATEMENT BY APPLICANT	Art Unit				
(Use as many sheets as necessary)	Examiner Name .				
Sheet 1 of 2	Altomey Docket Number	99-0068.3			

				DOCUMENTS	
Examinor initials*	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Potentee or Applicant of Cited Document	Peges, Columns, Lines, Where Relevant Passeges or Relevant Floures Appear
	L	Number-Kind Code <sup>3</sup> If brevel			1,400,747
VΨ	Α	US- 5,385,636	01/03/1995	Poingt et al.	
1	В	US- 5,674,785	10/07/1997	Akram et al.	
1	С	US- 5,677,566	10/14/1997	King	
	D	US- 5,739,585	04/14/1998	Akram et al.	
	Ε	US- 5,763,939	06/09/1998	Yamashita	
	F	US- 5,783,461	07/21/1998	Hembree	
1	G	US-5,811,879	09/22/1998	Akram	
_	Н	US- 5,834,945	11/10/1998	Akram et al.	$\Gamma - M$
	1	US- 5,885,849	03/23/1999	DiStefano et al.	_lX
1	J	US- 5,925,930	07/20/1999	Farnworth et al.	
	K	US- 5,956,605	09/21/1999	Akram et al.	T /. \
	T	US- 6,059,173	05/09/2000	Mays et al.	
	М	US- 6,063,647	05/16/2000	Chen et al.	
	N	us- 6,118,179	09/12/2000	Farnworth et al.	
	0	us- 6,180,504B1	01/30/2001	Farnworth et al.	
$\neg$	Р	US- 6,204,080	03/20/2001	Hwang	7
1.	a	US- 6,297,560	10/02/2001	Capote et al.	
V	R	us-6,352,881	03/05/2002	Nguyen et al.	7
174	s	US- 6,583,354	06/24/2003	Alcoe	-

		FORE	IGN PATENT DOCL	MENTS		_
Examiner Initials*	Cite		Publication Dete	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Pesseges	Γ.
		Country Code <sup>3</sup> "Number <sup>4</sup> "Kind Code <sup>6</sup> (# known)	MM-DD-YYYY		Or Relevant Figures Appear	۳
74	T	WO 99/21226	04/29/1999	Elenius et al.		
						L
	_					⊢
						١.
	1		1	1		

Examiner
Synature

FUNANCER: Initial I reference consistence, whether or not cleated is in conformance with IMPEP 600. Date the through cleated in Fine at conformance and many conformance and conformance and conformance and many conformance and conformance and conformance and confo

If you need assistance in completing the form, call 1-800-PTO-9199 (1-800-788-9199) and select option 2.

file 10/24/03

PTO/SB/088 (08-03)

Substitu	Substitute for form 1449/PTO		U.S. Pasent and Teacemark Office; U.S. DEPARTMENT OF COMMERCE re required to respond to a collection of Information unless II contains a valid OMB control number.  C mplet If Kn wn			
				Applicati n Number		
			SCLOSURE	Filing Date	10/24/2003	
STA	STATEMENT BY APPLICANT		First Named Inventor	WARREN M. FARNWORTH		
(Use as many sheets as necessary)		Art Unit				
(Ose as many sheets as necessary)			iocessary)	Examiner Name		
Sheet	2	of	2	Attorney Docket Number	99-0068.2	

Examiner	1.00	NON PATENT LITERATURE DOCUMENTS	
Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
VY	т	TUMMALA, RAO R., "Chip-to-Package Interconnections", Microelectronics Packaging Handbook, 1989, pgs 366-368, VanNostrand Reinhold (publisher), New York, NY.	~
V4	U	LAU, JOHN H., Ball Grid Array Technology, 1995, pgs 33, 47, 56, 133, 180, 247, 279, 475, 476-480, McGraw-Hill, Inc., United States.	_
14	, <b>v</b>	JOHN BALIGA, "Assembly & Packaging Wafer-Level Packages to Include Solder Ball Support", Nov. 27, 2000, pgs 1-2, Technology News.	_

Examiner	1. 11.		
Signature	V. Yeller	Date	02/11/0-
	V, TOOST VADO	Considered	04/16/05

EXAMINE: Intel I returned considered, where the second control of the second control of



PTO/SB/08A (08-03)
Approved for use through 07/31/2006, OMB 0651-0031
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a

Substitute for form 1449/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)

pond to a collection of inform	lavon unless it contains a valid OMB control numb	Dξ
C	omplete if Known	`
Application Number	10/693,380	_
Filing Date	10/24/2003	_
First Named Inventor	WARREN M. FARNWORTH	_
Art Unit	2812	_
Examiner Name		_

Attorney Docket Number 99-0068.3 Sheet 1 of 1 U. S. PATENT DOCUMENTS Peges, Columns, Lines, Where televant Pessages or Relevant Figures Appear Document Number MM-DD-YYYY Applicant of Cited Document No. Number-Kind Code<sup>2</sup> (Fire-In) V9 US- 6,524,346 B1 02/25/2003 Farnworth US- US 2003/0102566 VИ В 06/05/2003 Farnworth US-US-IIS. US us-US-US-US-US-US-US-US-US-US-

Examiner C Initials N	No.	Foreign Patent Document  Country Cose * Number * Head Code * (# Anown)	Publication Date MM-DD-YYYY	Name of Patentse or Applicant of Cited Document	Pages, Columns, Lines, Where Relevent Passages Or Retevant Figures Appear	۳
						Ē
						Н
						L

Superium V. 1 LUSTAGN Considered Considered

The individual control of the property of y 2 CFR 137 and 181. The information is required to detail to relate a benefit by the public which is to file (not by the USFO to process) in profession. Conditionally is powered by 3 VS. C. 22 and 2. of 2 and 1 on relate a benefit by the public which is somewhat in the complete, including spathengs presiding, and submitting the completed application form to be USFO? There 4. This collection is settinated to submit a complete application form to be USFO? There 4. This collection is settinated to a X-I/I over the submit of the case X-I/I overness on the amount of time you require to complete design form standing or benefit to the case X-I/I overness on the amount of time you require to complete the form most or supposed too for indicately but benefit, both or you can be submitted to X-I/I and X

If you need assistance in completing the form, call 1-800-PTO-9199 (1-800-786-9199) and select option 2.